

AP20 Rec'd PCT/PTO 04 MAY 2006

## INFORMATION DISCLOSURE STATEMENT

Applicant : Washio et al.  
App. No : Unknown  
Filed : Filed Herewith  
For : THICK FILM PHOTORESIST  
COMPOSITION AND METHOD OF  
FORMING RESIST PATTERN  
Examiner : Unassigned  
Art Unit : Unknown

## CERTIFICATE OF MAILING

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal Service as first-class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on

May 4, 2006

(Date)

Neil S. Bartfeld, Ph.D., Reg. No. 39,901

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

Enclosed for filing in the above-identified application is a PTO/SB/08 Equivalent listing 3 references to be considered by the Examiner. Also enclosed is 1 foreign patent reference and/or non-patent literature as listed on the Information Disclosure Statement.

This Information Disclosure Statement is being filed within three months of the filing date, with an RCE or before receipt of a first office action after an RCE and no fee is required.

The Commissioner is hereby authorized to charge any additional fees which may be required, or credit any overpayment, to Account No. 11-1410.

Respectfully submitted,

KNOBBE, MARTENS, OLSON &amp; BEAR, LLP

Dated: May 4, 2006

By:

Neil S. Bartfeld, Ph.D.  
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Application No.	Unknown
	Filing Date	Filed Herein <b>10/578398</b>
	First Named Inventor	Yasushi Washio
	Art Unit	Unknown
(Multiple sheets used when necessary)	Examiner	Unassigned
SHEET 1 OF 1	Attorney Docket No.	SHIGA7.049APC

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1	2003/0059706 A1	03-27-2003	Misumi et al.	
	2	5,965,328	10-12-1999	Sano et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T <sup>1</sup>
	3	JP 08-078318	03-22-1996	Naito Makiko		Abstract

2577057: cey  
050406

Examiner Signature	Date Considered
<p>*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>	

T<sup>1</sup> - Place a check mark in this area when an English language Translation is attached.